microgate 麦速科技

**AEC-O200** 

DATE:

**ROHS+HS** 

COMPLIANT

# APPROVAL SPECIFICATION

PRODUCT NAME: SMD power inductor

YOUR PART NO.:

OUR PART NO.: AMAPM1365FT Series

VERSION: V1.1

RECEPTION	~	Y
THE SPECIFIC	CATION HAS BEEN A	ACCEPTED.
COMPANY:	DAT	Έ:
CFMD	СНКД	RCVD

## MANUFACTURING NAME

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## CATALOG

	Component SPEC Version Record	3
1	Scope	4
2	Product Identification	4
3	Appearance, Dimensions and Material	4
4	Testing Conditions	5
5	Electrical Characteristics	5
6	Reliability	6-8
7	Recommended Soldering Condition	9
8	Packaging	10
9	Products Storage	11



## **Component SPEC Version Record**

Rev.	Effective Date	Changed Contents	Change Reasons	Approved By
V1.0	2019.11.02	New released	/	Charles
V1.1	2020.05.05	Update the specifications	/	Charles



## 1. Scope

This specification applies to the AMAPM1365FT series of SMD Power inductors.

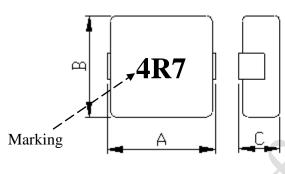
#### 2. Product Identification

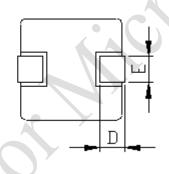
AMAPM	<u>1365FT</u>	<u>4R7</u>	M	- <u>LF</u>
(1)	2	3	4	5

- 1 Product Symbol (Automotive electronics products)
- ② Dimensions
- 3 Inductance Value (4R7:4.7uH 220: 22uH )
- ④ Inductance Tolerance (K:10%; M:20%; N:30%)
- ⑤ Lead-Free

## 3. Appearance, Dimensions and Material

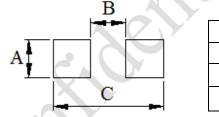
3.1 Appearance and dimensions





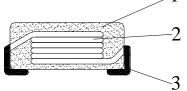
Dimensions in mm						
A B C D E						
14.5max. 13.0max. 6.5Max. 2.5±0.5 3.8±0.3						

3.2 Recommend Land Pattern



Dimensions in mm			
A 4.5			
В	8.0		
C 15.5			

3.3Material List



No.	Item	Material
1	Core	Alloy Material
2	Wire	Enameled Copper Wire
3	Terminal	Tin Covered Copper



## 4. Testing Conditions

Unless otherwise specified, the standard conditions for measurement/test as: Ambient Temperature : 5 to 35°C Relative Humidity: 25 to 85% RH Atmospheric Pressure: 86 to 106 kPa

If any doubt on the results, measurements/tests should be made within the following limits: Ambient Temperature :  $25\pm1$  °C Relative Humidity: 60 to 70% RH Atmospheric Pressure: 86 to 106 kPa

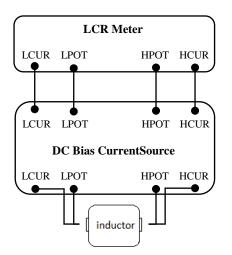
#### 5. Electrical Characteristics And Test Instruments

Miarogata Dart Na	Inductance DCR (m $\Omega$ )		Isat	Isat	Irms	Irms	
Microgate Part No.	L0 (uH) 100KHz/1V	Max	Тур.	(A) Max.	(A) Typ.	(A) Max.	(A) Typ.
AMAPM1365FT1R0M-LF	1.0±20%	2.1	1.9	27	30	30	34
AMAPM1365FT2R2M-LF	2.2±20%	4.5	4.0	23	25	19	23
AMAPM1365FT3R3M-LF	3.3±20%	6.0	5.0	22.0	22	16.5	18
AMAPM1365FT4R7M-LF	4.7±20%	9.3	8.1	18.2	21	12.5	14.5
AMAPM1365FT100M-LF	10±20%	20	17.5	13.5	16	10.2	10.8
AMAPM1365FT150M-LF	15±20%	28	24.3	10.5	12	8.5	9.6
AMAPM1365FT220M-LF	22±20%	40	35.5	9.0	10	7.0	8.4
AMAPM1365FT330M-LF	33±20%	69	60.2	7.2	8.4	5.5	6.4
AMAPM1365FT470M-LF	47±20%	104	90	6.6	7.0	4.2	4.8
AMAPM1365FT680M-LF	68±20%	145	130	5.0	6.2	3.45	4.0

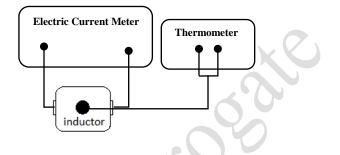
#### Test instruments and remarks

- \* All test data is referenced to  $25^{\circ}$ C ambient.
- \* L test by CHROMA 3302 meter or equivalent
- \* DCR test by Tonghui TH2516B meter or equivalent
- \* CHROMA 3302 and 1320 meter for IDC;
- \* Isat: DC current (A) that will cause L0 to drop approximately 30%.
- \* Irms: DC current (A) that will cause an approximate  $\Delta T$  of 40 °C.
- \* Operating temperature:  $-55^{\circ}$ C to  $+155^{\circ}$ C (Including self temperature rise).
- \* The part temperature (ambient + temp rise) should not exceed 155°C under worse case operating conditions. Circuit design, component placement, PCB trace size and thickness, airflow and other cooling provision all affect the part temperature. Part temperature should be verified in the end application.





Isat test schematic diagram



Irms test schematic diagram

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# 6. Reliability

No.	Item	Requirements	Test Methods and Remarks	Reference	Sample Size
1	Solderability	<ol> <li>No physical damage.</li> <li>Terminal area must have 95% min. solder coverage.</li> </ol>	<ol> <li>Temperature:245±5°C, flux 5-10 s.</li> <li>Sample immersion tin furnace 5 ±0.5s.</li> <li>Immersed and in and out of speed: 25 ± 6mm/s.</li> </ol>	AEC-Q200 (J-STD-002)	15
2	Resistance to Soldering Heat	<ul> <li>(1) No physical damage.</li> <li>(2)   ΔL0/L0   ≤10%</li> </ul>	<ul> <li>1) The peak temperature: 260+5/-0°C.</li> <li>2) Reflow: 3 times.</li> <li>(3) Temperature curve is as below:</li> <li>2650</li> <li>2650</li></ul>	AEC-Q200 (MIL-STD-202 Method 210)	30
3	High Temperature Storage	<ul> <li>(1) No physical damage.</li> <li>(2)   ΔL0/L0   ≤10%</li> </ul>	①Temperature: 155±2°C.         ②Time : 1000 hours.         ③Measurement at 24±4 hours after test conclusion.         Temperature 125°C         Room Temp.         0         1000H	AEC-Q200 (MIL-STD -202 Method 108)	77
4	Temperature Cycling	<ul> <li>(1) No physical damage.</li> <li>(2)   ΔL0/L0   ≤10%</li> </ul>	<ul> <li>①1000 cycles (-40°C to +155°C).</li> <li>②30min maximum dwell time at each temperature extreme. 1 min. maximum transition time.</li> <li>③Measurement at 24±4 hours after test conclusion.</li> </ul>	AEC-Q200 (JESD22-A104)	77
5	Resistance to Solvents	<ul> <li>(1) No physical damage.</li> <li>(2)   ΔL0/L0   ≤10%</li> </ul>	<ol> <li>Prepare solvent (isopropyl alcohol: kerosene: ethylbenzene =4:9:3 volume )</li> <li>Specimen be completely immersed in solvent for 3+0.5/-0min</li> <li>Brush dipped in solution until wetted and brush part 10 strokes .</li> <li>Repeat 2 more times, Air blow dry.</li> <li>Inspect at 3x magnifier for marking and 10x for part damage. Note: Add Aqueous wash chemical. OKEM Clean or equivalent. Do not use banned solvents.</li> </ol>	AEC-Q200 (MIL-STD-202 Method 215)	5



No.	Item	Requirements	Test Methods and Remarks	Reference	Sample
6	ESD	(1) No physical damage. (2) $\mid \Delta L0/L0 \mid \leq 10\%$	<ul> <li>①3 times in each of terminals and top side of component.</li> <li>②Direct contact discharge: 1C(1000V(DC) to &lt;2000V(DC))</li> </ul>	AEC-Q200 (AEC-Q200- 002)	<b>Size</b>
7	Biased Humidity	<ul> <li>(1) No physical damage.</li> <li>(2)   ΔL0/L0   ≤10%</li> </ul>	<ul> <li>①1000 hours, 85 ℃/85%RH.</li> <li>②Unpowered.</li> <li>③Measurement at 24±4 hours after test conclusion.</li> </ul>	AEC-Q200 (MIL-STD -202 Method 103)	77
8	Terminal Strength	<ul> <li>(1) No physical damage.</li> <li>(2)   ΔL0/L0   ≤10%</li> </ul>	<ul> <li>①The test samples shall be soldered to the board.</li> <li>②17.64N, 60s</li> <li>Radius 0.5mm</li> <li>DUT</li> <li>Radius 0.5mm</li> <li>Press tools</li> </ul>	AEC-Q200 (AEC-Q200-006)	30
9	Board Flex	<ul> <li>(1) No physical damage.</li> <li>(2)   ΔL0/L0   ≤10%</li> </ul>	<ul> <li>①Part mounted on a 100mm*40mm FR4 PCB board, which is 1.6±0.2 mm thick and as a Layer-thickness 35 μm ± 10 μm.</li> <li>②Bending speed is 1mm/s.</li> <li>③Keeping the P.C Board 2 mm minimum for 60 seconds.</li> </ul>	AEC-Q200 (AEC-Q200-005)	30
10	Vibration	<ul> <li>(1) No physical damage.</li> <li>(2)   ΔL0/L0   ≤10%</li> </ul>	<ul> <li>①Frequency range : 10~2000Hz.</li> <li>②Amplitude: 1.5mm, 5g.</li> <li>③Sweep time and duration: 10~2000~10Hz for 20 minutes.</li> <li>④Each four hours in X,Y,Z direction, 12 hours in total.</li> </ul>	AEC-Q200 (MIL-STD-202 Method 204)	30
11	Mechanical Shock	<ul> <li>(1) No physical damage.</li> <li>(2)   ΔL0/L0   ≤10%</li> </ul>	<ol> <li>Peak acceleration:100G/S</li> <li>Duration of pulse:6ms</li> <li>3times in each of 6(±X, ±Y, ±Z) axes.</li> </ol>	AEC-Q200 (MIL-STD-202 Method 213)	30

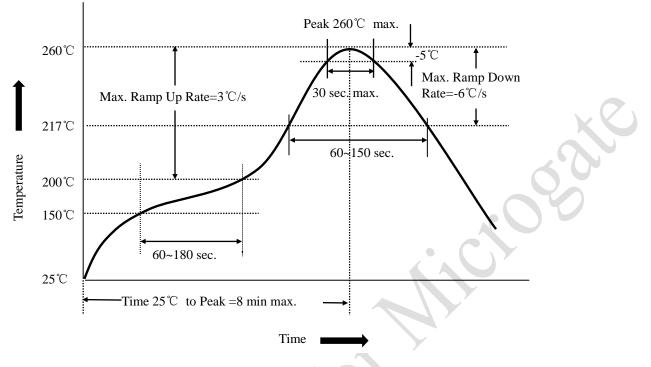


No.	Item	Requirements	Test Methods and Remarks	Reference	Sample Size
12	Loading at High Temperature	<ul> <li>(1) No physical damage.</li> <li>(2)   ΔL0/L0   ≤10%</li> </ul>	<ul> <li>①Temperature: 105±2°C.</li> <li>②Time : 1000 hours.</li> <li>③Applied Current : Rated current.</li> <li>④Measurement at 24±4 hours after test conclusion.</li> </ul>	AEC-Q200 (MIL-PRF-27)	77
13	Physical Dimension	According to specification	Verify physical dimensions to the applicable device detail specification.	AEC-Q200 (JESD22-B100)	30
14	Electrical Characterization	According to specification	Parametrically test per lot and sample size requirements, summary to show Min, Max, Mean and Standard deviation at room as well as Min and Max operating temperatures.	AEC-Q200 (User Spec.)	77

\*All above experiments items need 3 Lot., sample size is as specified in the table above. \*Sample size standard is from AEC-Q200 : qualification sample size requirements.



## 7. Recommended Soldering Conditions



(1) Reflow soldering conditions

\*Above reflow soldering curve is from J-STD-020D.

#### (2) Iron soldering

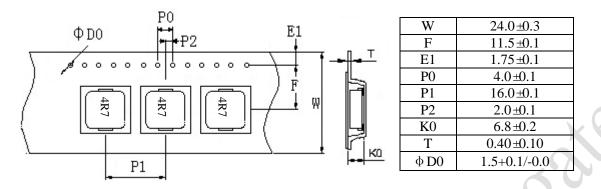
The following conditions must be strictly followed when using a soldering iron.

Pre-heating	150°C 1 minute	
Tip temperature	350℃ max	
Soldering iron output	30w max	
End of soldering iron	ф1mm max	
Soldering time	3 seconds max	

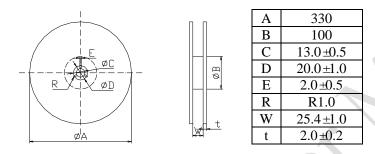


## 8.Packaging

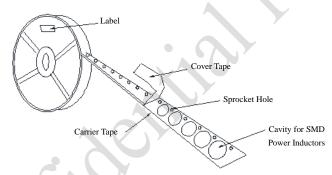
(1) Dimension of tape (Unit: mm)



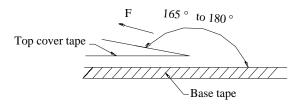
### (2) Dimension of reel (Unit: mm)



(3) Taping figure and drawing direction



- (4) Packaging quantities: 500PCS/Reel.
- (5) Peeling strength of cover tape:
  - The peel force of top cover tape shall be between 0.1N to 1.3 N. \*the peel force standard is from EIA-481-D



Room Temp. ( $^{\circ}C$ )	Room Humidity (%)	Room aim (hpa)	Peel Speed mm/min
5-35	45-85	860-1060	300



#### 9. Products Storage

(1) Storage period

Products which inspected in MICROGATE over 12 months ago should be examined and used, which can be confirmed with inspection No. marked on the container. Solderability should be checked if this period is exceeded.

(2) Storage conditions

Products should be storage in the warehouse on the following conditions: Temperature:  $-10 \sim +35$  °C Humidity: Less than 70% relative and humidity No rapid change on temperature and humidity.

- (3) Don't keep products in corrosive gases such as sulfur, chlorine gas or acid, or it may cause oxidization of electrode, resulting in poor solderability.
- (4) Products should be storage on the palette for the prevention of the influence from humidity, dust and so on.
- (5) Products should be storage in the warehouse without heat shock, vibration, direct sunlight and so on.
- (6) Products should be storage under the airtight packaged condition.